

U.S. PATENTS

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U.S. PATENT APPLICATION PUBLICATIONS

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FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL	FOREIGN PATENT DOCUMENT NUMBER	COUNTRY	KIND	PUBL. DATE (YYYY-MM-DD)	NAME OF PATENTEE OR APPLICANT OF THE CITED DOCUMENT	TRANSL	ATION NO
/S.C.	3727692	DE	C2	1989-03-02	Siemens AG	X	
/S.C./	4311327	DE	C2	1994-10-13	Siemens AG	Х	
/S.C./	2715822	FR	A1	1995-08-11	Edap Int	Х	
/S.C./	1-0248850	JP	Α	1998-09-22	Olympus Optical Co Ltd	Х	-

NON-PATENT LITERATURE DOCUMENTS

EXAMINER INITIAL	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial symposium catalog, etc.) date, page(s), volume-issue number(s), publisher, city and/or country where published.			
	2) Paristron and State (Page 6), Talante toda Adriba (6), Patriol (7), Old Charles County Miles Patriol Co.		YES	NO
EXAMINER	DATE CONSIDERED 07/30/2010			

EXAMINER: Indiad citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

(Form PTO-1449) 05-10-10 (1/1) 4 Refs